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U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No. <sup>1</sup>	Document No. Number - Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
EDB	A1	US-2003/0212446 A1	11-13-2003	Kaplan et al.
EDB	A2	US-2002/0111637 A1	08-15-2002	Kaplan et al.
EDB	A3	US-2002/0058925 A1	05-16-2002	Kaplan et al.
		US-		
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FOREIGN PATENT DOCUMENTS					
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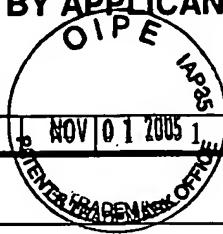
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23488/07961/DOCS/1587774.1

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Substitute for form 1449A/PTO		<b>Complete if Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>		Application No.	10/697,906
		Filing Date	October 29, 2003
		First Named Inventor	Albert K. Chin
		Art Unit	3731
		Examiner Name	Not Yet Known
		Attorney Docket Number	23488-07961
Sheet	1		



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Examiner Initials*	Cite No.	Document No. Number - Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
EA	A1	US-6,835,193 B2	12-28-2004	Epstein et al.

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Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> - Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>6</sup>

OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS				
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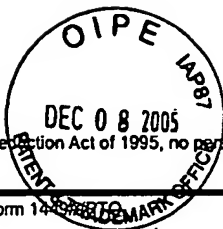
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23488/07961/DOCS/1569732.1



<b>Substitute for form 1449</b> <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>		<b>Complete If Known</b>			
		Application No.	10/697,906		
		Filing Date	October 29, 2003		
		First Named Inventor	Albert K. Chin		
		Art Unit	3766		
		Examiner Name	Eric D. Bertram		
Sheet	1	of	1	Attorney Docket Number	23488-07961

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EDB	C1	PCT International Search Report and Written Opinion; PCT/US04/34538, November 3, 2005, 10 pages	

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